

### **Aerated concrete microwave reflection and transmission properties in a wet environment**

**Koppel, Tarmo;** Vilcane, Inese; Mironovs, Viktors; Shishkin, Andrei; Rubene, Sanita; **Tint, Piia** Vide. Tehnologija. Resursi : XI starptautiskas zinātniski praktiskas konferences materiāli 2017. gada 15.-17. jūnijs. 3. sejums = Environment. Technology. Resources : proceedings of the 11th International Scientific and Practical Conference. Volume III 2017 / p. 145-149 : ill <https://doi.org/10.17770/etr2017vol3.2619>

### **Computer aided method for measurement of reflection and impedance characteristics of RF devices**

Asovich, P.L.; Zhukov, S.A.; Imanyuhin V.I. Automation, simulation & measurement : ASM'91 : 3rd biennial conference, Tallinn, October 7-11, 1991. Section A. Section M / Tallinn Technical University 1992 / p. 122-127: ill

### **COMSPECT : a compact model for green vegetation reflectance spectra in the 400–900 nm wavelength range**

**Udal, Andres; Jürise, Martin; Kaugerand, Jaanus; Sell, Raivo** Proceedings of the Estonian Academy of Sciences 2020 / p. 277-286 : ill <https://doi.org/10.3176/proc.2020.4.01> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

### **Londonisse kavandatakse ilma varjuta kõrghoonepaari. Pääkese peegeldamine nõuab ettevaatust**

#### **Pääkese peegeldamine nõuab ettevaatust**

Kiisler, Eva; **Voll, Hendrik** Ehitaja 2015 / lk. 26-28 : ill

### **Microwave reflection and absorption properties of wet snow**

**Koppel, Tarmo;** Haldre, Heldur; Shishkin, Andrei Riga Technical University 57th International Scientific Conference : "Scientific Conference on Economics and Entrepreneurship" (SCEE'2016) : proceedings 2016 / p. 170-171 : ill

### **Nonlinear propagation and reflection of ultrasound - combining the numerical and analytical approach**

**Braunbrück, Andres; Ravasoo, Arvi** 28th Nordic Seminar on Computational Mechanics, 22-23 October, Tallinn, 2015 : proceedings of the NSCM28 2015 / p. 39-42 : ill

### **On robust control and nice stability via reflection coefficients**

**Nurges, Ülo** Proceedings of the Estonian Academy of Sciences. Physics. Mathematics 1999 / 1, p. 31-47: ill

### **Reflection, rewinding, and coin-toss in EasyCrypt**

**Firsov, Denis;** Unruh, Dominique CPP 2022 - Proceedings of the 11th ACM SIGPLAN International Conference on Certified Programs and Proofs, co-located with POPL 2022 2022 / p. 166-179 <https://doi.org/10.1145/3497775.3503693>

### **Research and development of measurement solution and methodology for assessment of light reflection from surfaces = Mõõtelahenduse ja -metoodika uurimine ning arendamine pindadel valguse peegeldumise hindamiseks**

**Varjas, Toivo** 2021 [https://www.ester.ee/record=b5473279\\*est](https://www.ester.ee/record=b5473279*est) <https://digikogu.taltech.ee/et/Item/8a29147b-e21f-4273-aa1e-424bce74d20e> <https://doi.org/10.23658/taltech.60/2021>

### **Salt water sprayed paper microwave attenuation in shielding workplaces**

**Koppel, Tarmo;** Shishkin, Andrei; Haldre, Heldur Riga Technical University 57th International Scientific Conference : "Scientific Conference on Economics and Entrepreneurship" (SCEE'2016) : proceedings 2016 / p. 172-173 : ill

### **Snow microwave reflection at mobile phone frequency bands**

**Koppel, Tarmo;** Vilcane, Inese; **Tint, Piia;** Shishkin, Andrei Vide. Tehnologija. Resursi : XI starptautiskas zinātniski praktiskas konferences materiāli 2017. gada 15.-17. jūnijs. 1. sejums = Environment. Technology. Resources : proceedings of the 11th International Scientific and Practical Conference, June 15-17, 2017. Volume I 2017 / p. 156-160 : ill <http://dx.doi.org/10.17770/etr2017vol1.2608>

### **Temperature dependent electroreflectance study of CdTe solar cells**

**Raadik, Taavi; Krustok, Jüri; Josepson, Raavo; Hiie, Jaan;** Potlog, Tamara; **Spalatu, Nicolae** Thin solid films 2013 / p. 279-282 : ill <https://doi.org/10.1016/j.tsf.2012.12.083> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

### **Temperature dependent electroreflectance study of Cu<sub>2</sub>ZnSnSe<sub>4</sub> solar cells**

**Krustok, Jüri; Raadik, Taavi; Grossberg, Maarja;** Giraldo, Sergio; Neuschitzer, Markus; Lopez-Marino, Simon; Saucedo, Edgardo Materials science in semiconductor processing 2015 / p. 251-254 : ill <http://dx.doi.org/10.1016/j.mssp.2015.04.055>

### **Temperature dependent optical and electrical characterization of SnS/CdS solar cell**

**Raadik, Taavi; Spalatu, Nicolae; Krustok, Jüri; Josepson, Raavo; Grossberg, Maarja** Thin Solid Films 2022 / art. 139069 <https://doi.org/10.1016/j.tsf.2021.139069> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

### **Use of ultrasound reflection tomography for nondestructive testing**

Jasiuniene, E.; Mažeika, L. BEC'98 : the 6th Biennial Conference on Electronics and Microsystems Technology, October 7-9, 1998, Tallinn, Estonia : proceedings 1998 / p. 345-346